Application/Control No. Applicant(s)/Patent Under Reexamination NAKAZAWA ET AL. Examiner Lois Zheng Application/Control No. Applicant(s)/Patent Under Reexamination NAKAZAWA ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,484,512	01-1996	Sasaki et al.	205/628
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